

HM2302-VB Datasheet

N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A) ^e	Q _g (Typ.)			
	0.028 at V _{GS} = 4.5 V	6 ^a				
20	0.042 at V _{GS} = 2.5 V	6 ^a	8.8 nC			
	0.050 at V _{GS} = 1.8 V	5.6				

SOT-23

3 D

G 1

S 2

FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- DC/DC Converters
- Load Switch for Portable Applications

Top View					
ABSOLUTE MAXIMUM RATIN	I GS T _A = 25 °C,	unless otherwise	e noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 12	V	
	T _C = 25 °C		6 ^a		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C		5.1		
Continuous Drain Current $(1) = 150^{\circ}$ C)	T _A = 25 °C	I _D	5 ^{b, c}		
	T _A = 70 °C		4 ^{b, c}	A	
Pulsed Drain Current	•	I _{DM}	20		
Continuous Source-Drain Diode Current	T _C = 25 °C		1.75		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.04 ^{b, c}		
	T _C = 25 °C		2.1		
Maximum Bower Dissipation	T _C = 70 °C		1.3	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.25 ^{b, c}	vv	
	T _A = 70 °C		0.8 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	80	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	40	60	C/W		

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 125 °C/W.

e. Based on T_C = 25 °C.



FREE

$\begin{array}{ c c c c c c } \hline Parameter & Symbol & Test Conditions & Min. & Typ. & Max. & Unit \\ \hline Static & & & & & & & & & & & & & & & & & & &$	SPECIFICATIONS $T_J = 25 \text{ °C}$, unless otherwise noted						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Static						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I _D = 250 µA	20			V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		25		m\//°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η - 200 μλ		- 2.6		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	0.45		1.0	V
	Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		lana	$V_{DS} = 20 V, V_{GS} = 0 V$			1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	DSS	V_{DS} = 20 V, V_{GS} = 0 V, T_{J} = 70 °C			10	μΑ
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	On-State Drain Current ^a	I _{D(on)}	$V_{DS}{\leq}5$ V, $V_{GS}{=}4.5$ V	20			A
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$			$V_{GS} = 4.5 \text{ V}, I_D = 5.0 \text{ A}$		0.028		
Forward Transconductance ^a g_{fs} $V_{DS} = 10 \text{ V}, I_D = 5.0 \text{ A}$ 24SDynamic ^b Input Capacitance C_{iss} $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ 865 PF	Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 4.7 \text{ A}$		0.042		Ω
Dynamic ^b 865 Input Capacitance C _{iss} Output Capacitance C _{oss} V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz 105		-	$V_{GS} = 1.8 \text{ V}, I_D = 4.3 \text{ A}$		0.050		
Input Capacitance C _{iss} 865 Output Capacitance C _{oss} V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz 105 pF	Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$		24		S
Output Capacitance C_{oss} $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ 105pF	Dynamic ^b				•	•	•
	Input Capacitance	C _{iss}			865		
	Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		105		pF
	Reverse Transfer Capacitance				55		
$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 5 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$ 12 18		0	$V_{DS} = 10 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 5.0 \text{ A}$		12	18	
Total Gate Charge $Q_g = \frac{V_{DS} - 10V, V_{GS} - 5V, I_D - 5.0 A}{8.8}$	Total Gate Charge	Qg			8.8	14	nC
Gate-Source Charge Q_{gs} $V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5.0 \text{ A}$ 1.1	Gate-Source Charge	Q _{gs}	$V_{DS} = 10$ V, $V_{GS} = 4.5$ V, $I_{D} = 5.0$ A		1.1		
Gate-Drain Charge Q _{gd} 0.7	Gate-Drain Charge	Q _{gd}			0.7		
Gate Resistance R_g f = 1 MHz 0.5 2.4 4.8 Ω	Gate Resistance	Rg	f = 1 MHz	0.5	2.4	4.8	Ω
Turn-On Delay Time t _{d(on)} 8 16	Turn-On Delay Time	t _{d(on)}			8	16	
Rise Time t_r V_{DD} = 10 V, R_L = 2.2 Ω 17 26	Rise Time	t _r	BB E		17	26	
Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ 3147	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		31	47	1
Fall Timetf816ns	Fall Time				8	16	ns
Turn-On Delay Time t _{d(on)} 5 10	Turn-On Delay Time	t _{d(on)}			5	10	
Rise Time t_r $V_{DD} = 10 \text{ V}, \text{ R}_L = 2.2 \Omega$ 13 20	Rise Time		55 5		13	20	-
Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 4 \text{ A}, V_{GEN} = 5 \text{ V}, R_g = 1 \Omega$ 2132	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4 \text{ A}, V_{GEN} = 5 \text{ V}, R_g = 1 \Omega$		21	32	
Fall Time t _f 6 12	Fall Time	t _f			6	12	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode CurrentIs $T_C = 25 \ ^{\circ}C$ 1.75	Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			1.75	•
Pulse Diode Forward Current I _{SM} A	Pulse Diode Forward Current	I _{SM}				20	A
Body Diode Voltage V _{SD} I _S = 4 A, V _{GS} = 0 V 0.75 1.2 V	Body Diode Voltage	V_{SD}	$I_{S} = 4 A, V_{GS} = 0 V$		0.75	1.2	V
Body Diode Reverse Recovery Time trr 12 20 ns	Body Diode Reverse Recovery Time	t _{rr}			12	20	ns
Body Diode Reverse Recovery Charge Q_{rr} $I_F = 4 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ 510nC	Body Diode Reverse Recovery Charge	Q _{rr}	L = 4.4 dl/dt = 100.4/up T = 25.00		5	10	nC
Reverse Recovery Fall Time t _a	Reverse Recovery Fall Time	t _a	$F = 4 A$, ui/ui = 100 A/µs, $T_{\rm J} = 25 C$		7	T	
Reverse Recovery Rise Time t _b 5	Reverse Recovery Rise Time	t _b			5		ns

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi

www.VBsemi.com



- 55 °C

1.5

20

T_C =

15

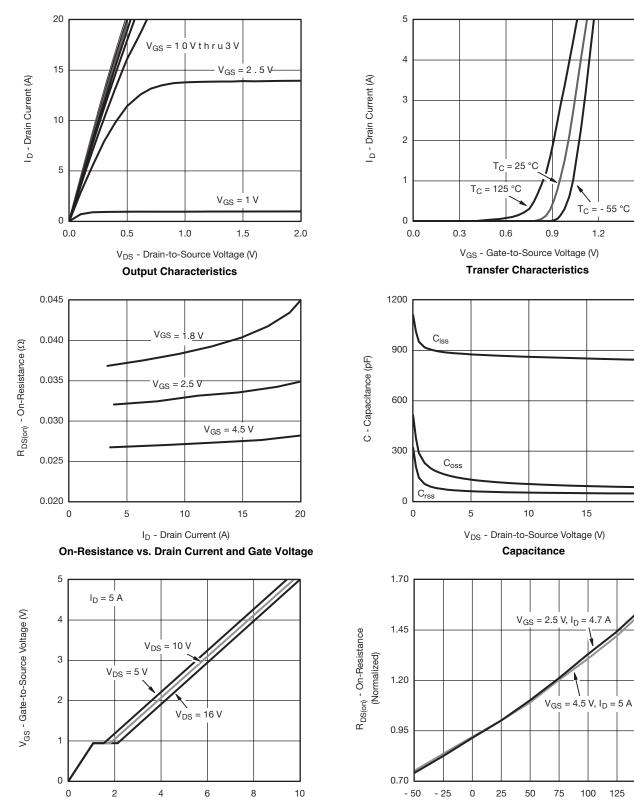
100

T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature

125 150

1.2

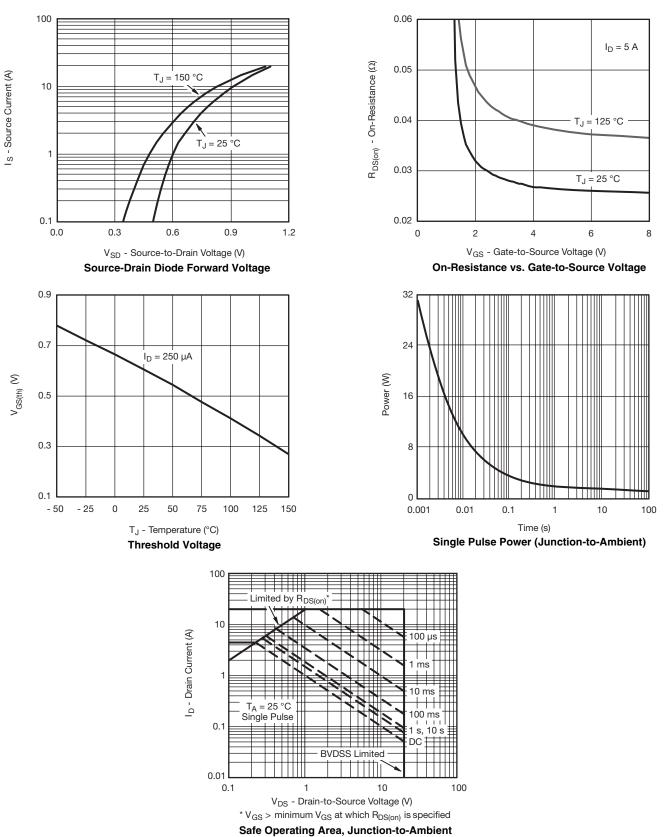


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Q_q - Total Gate Charge (nC)

Gate Charge

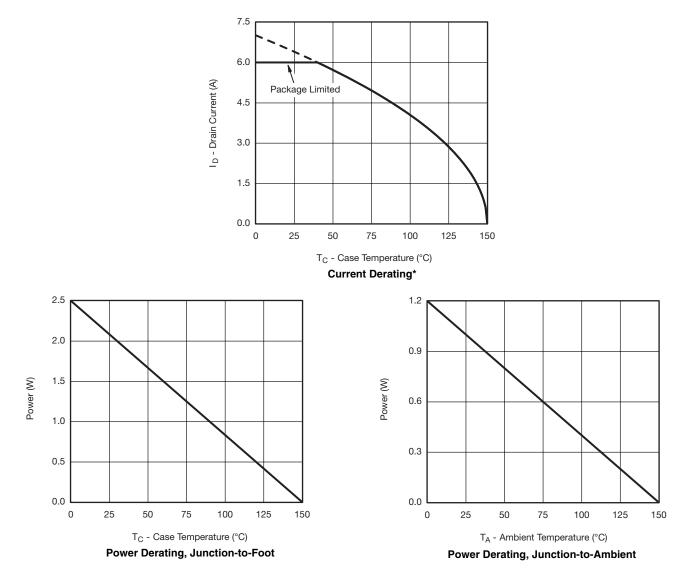




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



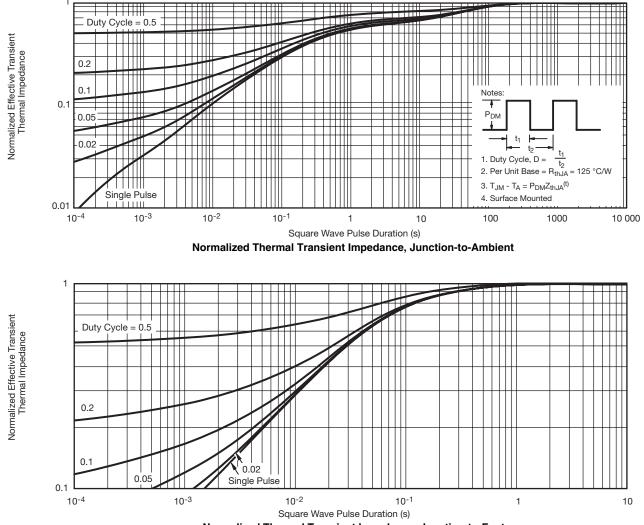
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







SOT-23 (TO-236): 3-LEAD



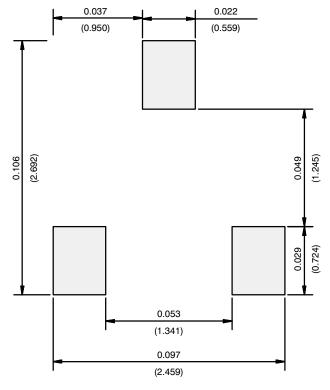




Dim	MILLIN	IETERS	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A ₁	0.01	0.10	0.0004	0.004		
A ₂	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
С	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E ₁	1.20	1.40	0.047	0.055		
е	0.95 BSC		0.0374 Ref			
e ₁	1.90 BSC		0.0748 Ref			
L	0.40	0.60	0.016	0.024		
L ₁	0.64 Ref		0.025	0.055 Ref Ref 0.024		
S	0.50 Ref		0.020	0.020 Ref		
q	3°	8°	3°	8°		
ECN: S-03946-Rev. K, 09- DWG: 5479	Jul-01					



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

Taiwan VBsemi Electronics Co., Ltd., branches, agents, employees, and all persons acting on its or their representatives (collectively, the "Taiwan VBsemi"), assumes no responsibility for any errors, inaccuracies or incomplete data contained in the table or any other any disclosure of any information related to the product.(www.VBsemi.com)

Taiwan VBsemi makes no guarantee, representation or warranty on the product for any particular purpose of any goods or continuous production. To the maximum extent permitted by applicable law on Taiwan VBsemi relinquished: (1) any application and all liability arising out of or use of any products; (2) any and all liability, including but not limited to special, consequential damages or incidental; (3) any and all implied warranties, including a particular purpose, non-infringement and merchantability guarantee.

Statement on certain types of applications are based on knowledge of the product is often used in a typical application of the general product VBsemi Taiwan demand that the Taiwan VBsemi of. Statement on whether the product is suitable for a particular application is non-binding. It is the customer's responsibility to verify specific product features in the products described in the specification is appropriate for use in a particular application. Parameter data sheets and technical specifications can be provided may vary depending on the application and performance over time. All operating parameters, including typical parameters must be made by customer's technical experts validated for each customer application. Product specifications do not expand or modify Taiwan VBsemi purchasing terms and conditions, including but not limited to warranty herein.

Unless expressly stated in writing, Taiwan VBsemi products are not intended for use in medical, life saving, or life sustaining applications or any other application. Wherein VBsemi product failure could lead to personal injury or death, use or sale of products used in Taiwan VBsemi such applications using client did not express their own risk. Contact your authorized Taiwan VBsemi people who are related to product design applications and other terms and conditions in writing.

The information provided in this document and the company's products without a license, express or implied, by estoppel or otherwise, to any intellectual property rights granted to the VBsemi act or document. Product names and trademarks referred to herein are trademarks of their respective representatives will be all.

Material Category Policy

Taiwan VBsemi Electronics Co., Ltd., hereby certify that all of the products are determined to be oHS compliant and meets the definition of restrictions under Directive of the European Parliament 2011/65 / EU, 2011 Nian. 6. 8 Ri Yue restrict the use of certain hazardous substances in electrical and electronic equipment (EEE) - modification, unless otherwise specified as inconsistent.(www.VBsemi.com)

Please note that some documents may still refer to Taiwan VBsemi RoHS Directive 2002/95 / EC. We confirm that all products identified as consistent with the Directive 2002/95 / EC European Directive 2011/65 /.

Taiwan VBsemi Electronics Co., Ltd. hereby certify that all of its products comply identified as halogen-free halogen-free standards required by the JEDEC JS709A. Please note that some Taiwanese VBsemi documents still refer to the definition of IEC 61249-2-21, and we are sure that all products conform to confirm compliance with IEC 61249-2-21 standard level JS709A.